Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,834	CHEN, WEN CHOU	
Examiner	Art Unit	

KEVIN L. LEE

3753

SEARCHED					
Class	Subclass	Date	Examiner		
UPDATED	SEARCH	8/15/2006	KL		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			 		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Interference search (US-PGPUB)	8/15/2006	KL		
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